

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/713,005	INOUE ET AL.
	Examiner	Art Unit
	Hau H. Nguyen	2628

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
345	545, 531	10/6/2006	HN
	533		
see attached			